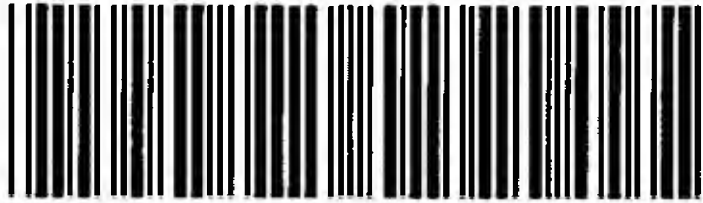


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/734,159	TWIG ET AL.	
	Examiner	Art Unit	
	Susan Y. Chen	2161	

SEARCHED			
Class	Subclass	Date	Examiner
707	3	6/16/2006	TYC
707	10	6/16/2006	TYC
715	738	6/16/2006	TYC
705	26	6/16/2006	TYC
705	14	6/16/2006	TYC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Texts search on East DB	6/16/2006	TYC
Consults with QA - Pat Salce for Double Patenting and 101 rejections	6/16/2006	TYC
Palm inventor search	6/16/2006	TYC
NPL -IEEE, ACM, Google text search	6/19/2006	TYC